

# AO3400

# 30V N-Channel MOSFET

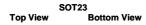
# **General Description**

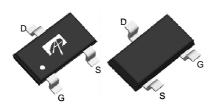
The AO3400 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\rm DS(ON)}.$  This device is suitable for use as a load switch or in PWM applications.

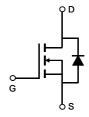
# **Product Summary**

 $\begin{array}{lll} V_{DS} & 30V \\ I_D \ (at \ V_{GS} \! = \! 10V) & 5.8A \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 10V) & < 28m\Omega \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 4.5V) & < 33m\Omega \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 2.5V) & < 52m\Omega \end{array}$ 









# Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		V <sub>GS</sub>	±12	V
Continuous Drain	T <sub>A</sub> =25℃		5.8	
Current	T <sub>A</sub> =70℃	'D	4.9	A
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	30	
	T <sub>A</sub> =25℃	В	1.4	W
Power Dissipation <sup>B</sup>	r Dissipation B $T_A=70^{\circ}$		0.9	vv
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	70	90	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	100	125	€/M			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		30			V			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =30V, $V_{GS}$ =0V				1	μΑ			
·DSS			T <sub>J</sub> =55℃			5	μπ			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±12V				100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		0.65	1.05	1.45	V			
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V		30			Α			
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_{D}$ =5.8A			18	28	mΩ			
			T <sub>J</sub> =125℃		28	39	11122			
		$V_{GS}$ =4.5V, $I_{D}$ =5A			19	33	mΩ			
		$V_{GS}$ =2.5V, $I_{D}$ =4A		24	52	mΩ				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =5.8A			33		S			
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.7	1	V			
Is	Maximum Body-Diode Continuous Curre	ent			2	Α				
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz		500	630	760	pF			
Coss	Output Capacitance			50	75	100	pF			
$C_{rss}$	Reverse Transfer Capacitance			30	50	70	pF			
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		1.5	3	4.5	Ω			
SWITCHII	NG PARAMETERS									
$Q_g$	Total Gate Charge	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, I <sub>D</sub> =5.8A		4.8	6	7	nC			
$Q_{gs}$	Gate Source Charge			1	1.3	1.6	nC			
$Q_{gd}$	Gate Drain Charge			1	1.8	2.5	nC			
t <sub>D(on)</sub>	Turn-On DelayTime	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =2.6 $\Omega$ , $R_{GEN}$ =3 $\Omega$			3		ns			
t <sub>r</sub>	Turn-On Rise Time				2.5		ns			
t <sub>D(off)</sub>	Turn-Off DelayTime				25		ns			
t <sub>f</sub>	Turn-Off Fall Time				4		ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =5.8A, dI/dt=100A/μs		7	8.5	10	ns			
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =5.8A, dI/dt=100A/μ	เร	2	2.6	3.1	nC			

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using  $\leqslant$  10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initialT<sub>.1</sub>=25° C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

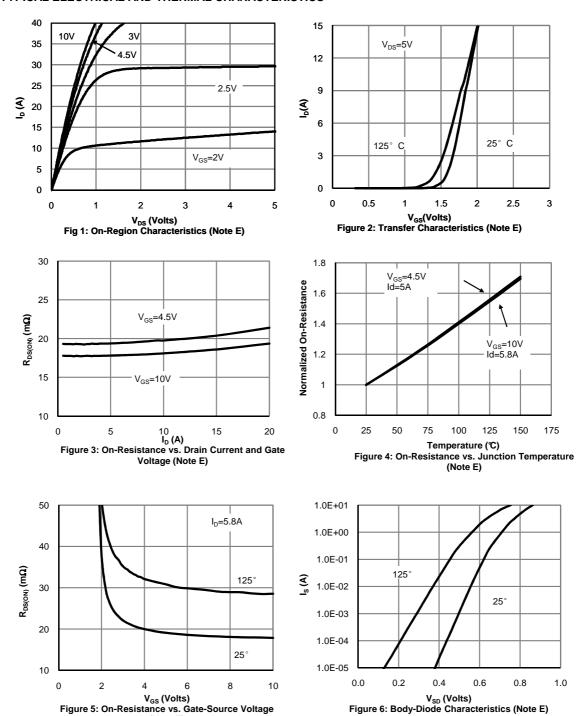
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(\text{MAX})}$ =150° C. The SOA curve provides a single pulse rating.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





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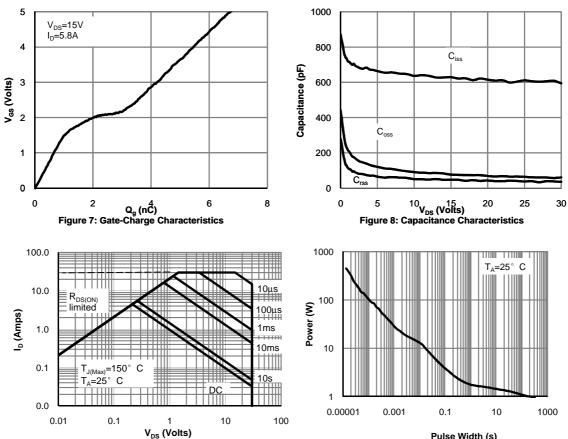
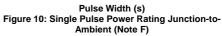


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



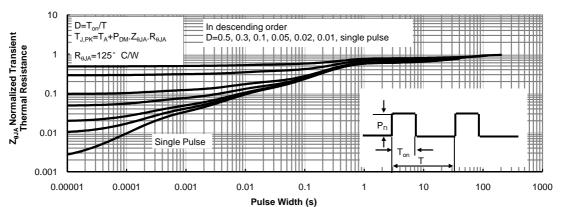
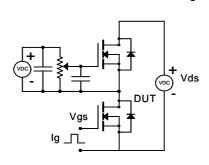
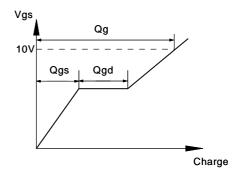


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

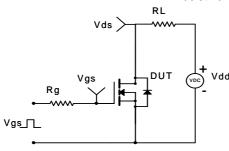


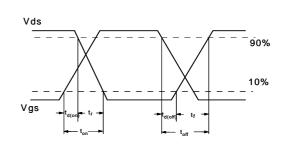
# Gate Charge Test Circuit & Waveform





# Resistive Switching Test Circuit & Waveforms





### Diode Recovery Test Circuit & Waveforms

